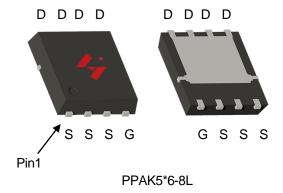


Single N-Channel Enhancement Mode MOSFET

Feature Description

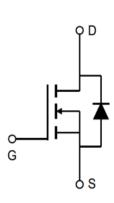
- 40V/65A
 - $R_{DS(ON)}=5.1m\Omega(typ.)@V_{GS}=10V$
 - $R_{DS(ON)} = 6.2 m\Omega(typ.) @V_{GS} = 4.5 V$
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen- Free Devices Available

Pin Description



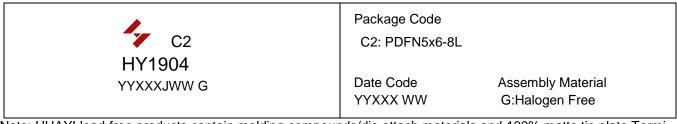
Applications

- High Frequency Point-of-Load Synchronous Buck Converter
- Power Tool Application
- Networking DC-DC Power System



Single N-Channel MOSFET

Ordering and Marking Information



Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Rat	ings (Tc=25°C Unless Otherwise Noted)			
VDSS	Drain-Source Voltage		40	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		150	°C
Тѕтс	Storage Temperature Range		-55 to 150	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		65	А
Mounted on I	Large Heat Sink			
Ідм	Pulsed Drain Current *	Tc=25°C	260	А
1		Tc=25°C	65	А
lσ	Continuous Drain Current	Tc=100°C	41	А
Г.	Manifesture Description	Tc=25°C	48	W
Po	Maximum Power Dissipation	Tc=100°C	19	W
R₀JC	Thermal Resistance, Junction-to-Case		2.6	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient **		35	°C/W
Eas	SinglePulsed-Avalanche Energy *** L=0.1mH		145	mJ

Note:

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Surface mounted on 1in2 FR-4 board.
- *** Limited by TJmax , starting TJ=25°C, L = 0.1mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Cumbal	Davamatar	Toot Conditions	HY1904			Unit	
Symbol	ymbol Parameter Test Conditions		Min	Тур.	Max		
Static Char	Static Characteristics						
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	40	-	-	V	
Ipss	Drain-to-Source Leakage Current	V _{DS} =40V,V _{GS} =0V	-	-	1	μA	
IDSS		TJ=55°C	ı	-	5	μA	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	1	1.7	3	V	
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA	
Process*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =20A	-	5.1	6	mΩ	
Rds(on)*		V _{GS} =4.5V,I _{DS} =20A	-	6.2	7		
Diode Characteristics							
Vso*	Diode Forward Voltage	IsD=20A,Vgs=0V	-	0.8	1.2	V	
trr	Reverse Recovery Time	lon-2014 dlon/dt-1001///	-	23	-	ns	
Qrr	Reverse Recovery Charge	Isp=20A,dIsp/dt=100A/µs	-	58	-	nC	



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cymbal	Davamatar	Toot Conditions	HY1904	Unit		
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Dynamic (Dynamic Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	1.5	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	2391	-	
Coss	Output Capacitance	VDS=25V,	-	359	-	рF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	195	-	
td(ON)	Turn-on Delay Time		-	13	-	
Tr	Turn-on Rise Time	V _{DD} =20V,R _G =3.3Ω, I _{DS} =20A,V _{GS} =10V	-	11	-	20
td(OFF)	Turn-off Delay Time		-	41	-	ns
Tf	Turn-off Fall Time		-	14	-	
Gate Charge Characteristics						
Qg	Total Gate Charge	\/ _22\/ \/ _10\/	-	56.5	-	
Qgs	Gate-Source Charge	$V_{DS} = 32V, V_{GS} = 10V,$ - $I_{D} = 20A$	-	5.1	-	nC
Qgd	Gate-Drain Charge	ID=ZUA	-	13.5	-	

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristics

Figure 1: Power Dissipation

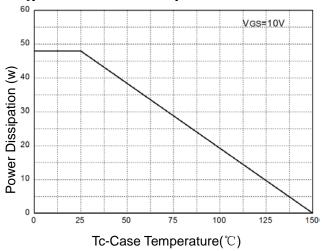


Figure 3: Safe Operation Area

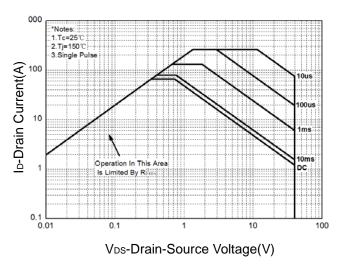


Figure 5: Output Characteristics

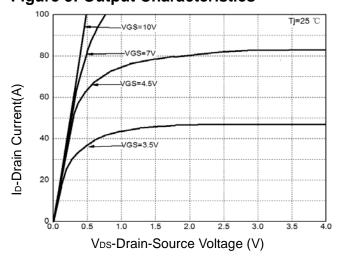


Figure 2: Drain Current

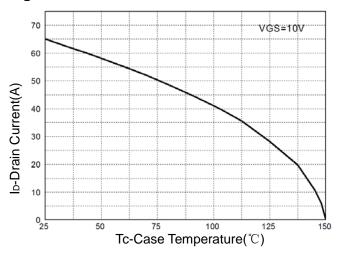
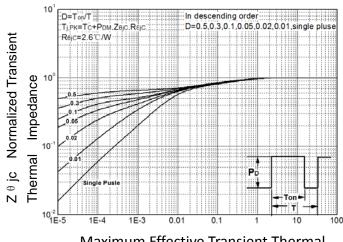
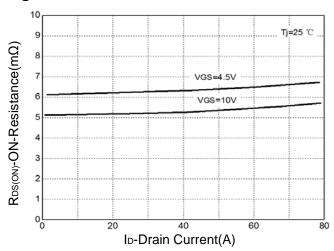


Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal Impedance, Junction-to-Case

Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

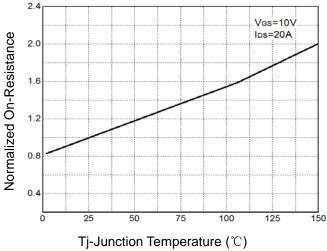


Figure 9: Capacitance Characteristics

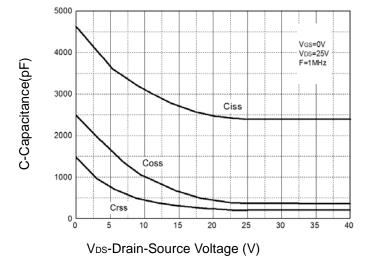


Figure 8: Source-Drain Diode Forward

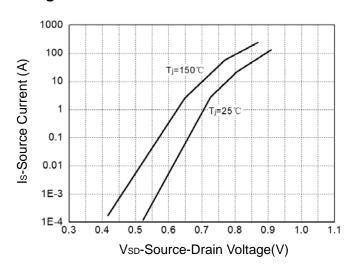
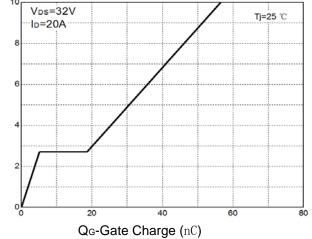


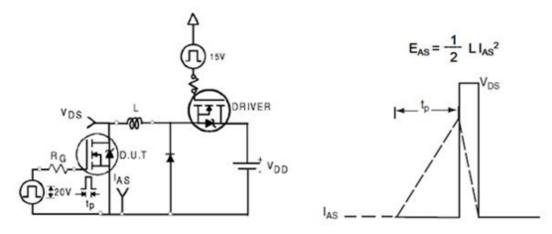
Figure 10: Gate Charge Characteristics



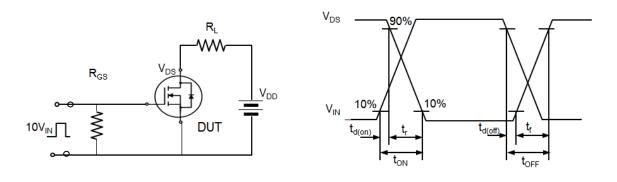




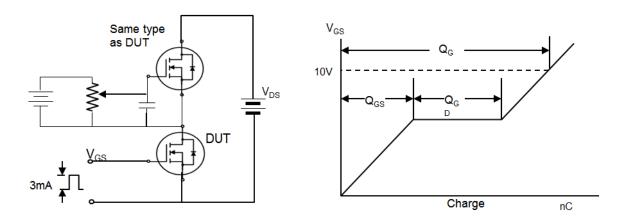
Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Gate Charge Test Circuit and Waveforms



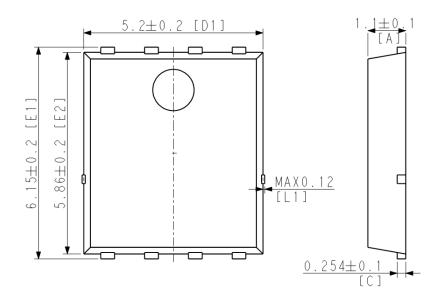


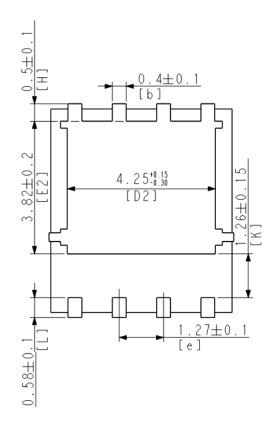
Device Per Unit

Package Type	Unit	Quantity
PDFN5x6-8L	Reel	5000

Package Information

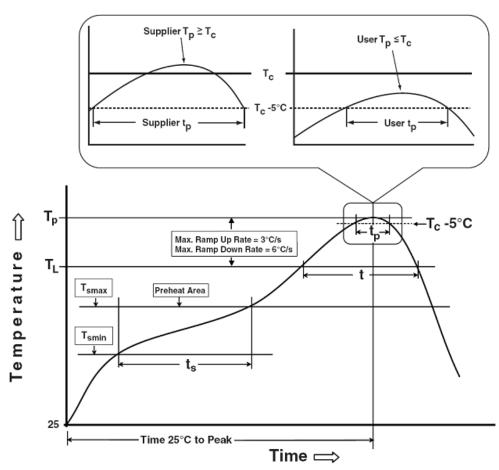
PDFN5x6-8L







Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly		
Preheat & Soak Temperature min (T _{smin}) Temperature max (T _{smax}) Time (Tsmin to Tsmax) (t _s)	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds		
Average ramp-up rate (T _{smax} to T _P)	3 °C/second max.	3°C/second max.		
Liquidous temperature (T _L)	183 °C	217 °C		
Time at liquidous (t∟)	60-150 seconds	60-150 seconds		
Peak package body Temperature (T _P)*	See Classification Temp in table 1	SeeClassification Tempin table 2		
Time (t _P)** within 5°C of the specified classification temperature (T _c)	20** seconds	30** seconds		
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.		
Time 25°C to peak temperature	6 minutes max.	8 minutes max.		
*Tolorance for peak profile Temporature (T.) is defined as a supplier minimum and a user maximum				

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168 Hrs /500 Hrs /1000 Hrs, Bias @ 150℃
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121℃
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

Worldwide Sales and Service: sales@hymexa.com Technical Support:Technology@hymexa.com Xi'an Huayi Microelectronics Co., Ltd.

No.8928, Shangji Road, Economic and Technological Development Zone, Xi'an, China

TEL: (86-029) 86685706 FAX: (86-029) 86685705 E-mail: sales@hymexa.com Web net: www.hymexa.com